Application of bow-tie surface plasmon antenna to silicon on insulator nanowire photodiode for enhanced light absorption

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Abstract: Down scaling of photodetectors is one of the major approaches to enhance their performance in terms of operation speed, dark current and sensitivity to photogenerated carriers. In order to compensate for the drawback of the down scaling, i.e. the reduction of light absorption efficiency and light receiving area, this report introduces the bow-tie surface plasmon nanoantenna for silicon on insulator (SOI) nanowire photodiode and clarifies its spectroscopic response. The bow-tie structure has a light sensitive area in the scale of the wavelength, and resonantly enhances the electric field near the central gap resulting in increased generation of carriers in the silicon nanowire, which is experimentally verified and analyzed by electromagnetic simulation.

Keywords: bow-tie optical nanoantenna, silicon-on-insulator (SOI), surface plasmon, photodiode

Classification: Integrated optoelectronics

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1 Introduction

In order to improve the speed performance of photodetectors, reduction of sizes is effective since carrier transit time and also the resistance-capacitance (RC) time constant can be reduced [1]. Size reduction also helps reducing the dark current (or dark count in case of single-photon detection) because of the less amount of generation centers included in the device. In addition, reduced capacitance leads to a larger charge-to-voltage conversion gain that is important for active pixel sensors [2] and some single-photon detectors [3, 4]. The effectiveness of the down scaling is enhanced especially when photodetectors are fabricated on silicon on insulator (SOI) substrates [5, 6, 7] as the parasitic capacitance is further reduced by the low-permittivity dielectric isolation, and the detector is perfectly separated from the thick substrate that can be a source of the dark current.

However, the downscaling of photodetectors has the serious drawback of the reduced light absorption efficiency and light receiving area. The introduction of an optical antenna that can concentrate light into a small volume is expected to alleviate the drawback and make the best use of the scaled-down photodetectors. Recently, the use of surface plasmon (SP) resonance is drawing attention to realize such an optical antenna. Ishi, *et al.* utilized a silver (Ag) concentric grating to generate SP and concentrate light on the small aperture at the center where a subwavelength silicon (Si) mesa photodiode (PD) was located [8]. Similar concentric and one-dimensional (line-and-space) gratings made of SP media, such as gold (Au), Ag and aluminum (Al), were also applied to metal-semiconductor-metal (MSM) [9, 10, 11] and metal-oxide-semiconductor (MOS) [12, 13] PDs although the propagating SP mode was not always employed, and the ability to expand the light receiving area was limited. Localized SP in Au nanoparticles and nanorods was reported to enhance the sensitivity of pn junction [14, 15, 16], MOS [17, 18] and Schottky [19] PDs, but they were not intended for scaled-down photodetectors with advantages mentioned above.

In this work, we report the application of the Au bow-tie SP antenna to nanowire SOI pn junction PD for the enhanced light absorption. The bow-tie structure consists of two triangles facing each other with a nanogap between them, where intense field is created [20, 21, 22] to enhance the light absorption in the nanowire placed nearby. The advantage of this structure is the small intersectional

area between the antenna and the nanowire PD, which minimizes the increase in parasitic capacitance. To our knowledge, this is the first time for the bow-tie nanoantenna to be applied to the scaled-down PD, although it has been intensively researched for enhancing Raman scattering [23, 24, 25] and molecular fluorescence [26]. Here, we verify the enhancement of the light absorption in the nanowire PD experimentally, and analyze the antenna operation by electromagnetic simulation. Unique fabrication technique of nanogap in the bow tie by electromigration, which realizes single-digit nanometer gap, is also introduced for the first time.

2 Device structure and fabrication

2.1 Device structure

The structure of SOI nanowire PD with bow-tie nanoantenna is shown in Fig. 1(a). The channel of the PD connecting the cathode and anode, is in the form of nanowire of designed width (W_{Si}) of 150 nm. As shown in Fig. 1(b), the nanoantenna is in the shape of a bow-tie.

The designed antenna length (L_{ANT}) ranges from 240 to 400 nm, and designed channel length (L_C) of the SOI PD is from 40 to 72 nm. Initially, the bow-tie is closed, but a nanogap can be created afterward by electromigration [27] at the junction as highlighted. Au is used as a material for bow-tie nanoantenna because of its inertness, i.e. its surface is more stable in atmospheric conditions compared to other SP media such as Ag. The bow-tie nanoantenna is designed as a half-wavelength antenna, i.e. L_{ANT} is a half of the SP propagation wavelength (λ_{SP}) as shown in the inset of Fig. 2(a).

Effective refractive index for the SP mode along Au/vacuum interface is given by

$$n_{eff} = \sqrt{\varepsilon_1 \varepsilon_2 / (\varepsilon_1 + \varepsilon_2)}, \quad (1)$$

where, ε_1 and ε_2 are dielectric constants of vacuum and Au, respectively. λ_{SP} along the Au/vacuum interface is given by

$$\lambda_{SP} = \frac{\lambda_0}{\text{Re}\{n_{eff}\}}. \quad (2)$$

Fig. 1. (a) Device structure of bow-tie nanoantenna on SOI PD, (b) Enlarged image of bow-tie nanoantenna in fabricated SOI PD.

As seen from Fig. 2(a), λ_{SP} is not largely deviated from the wavelength in vacuum (λ_0), and therefore $L_{ANT} = 240 \sim 400$ nm is chosen to cover the visible wavelength. Attenuation of SP for half-SP-wavelength propagation is given by

$$\text{Extinction ratio} = 1 - e^{-\frac{4\pi \text{Im}\{n_{eff}\}}{\lambda_0} \times \frac{\lambda_{SP}}{2}}. \quad (3)$$

At $\lambda_0 < 550$ nm, interband transition occurs in Au, and SPs are absorbed as shown in Fig. 2(b), and as the result, antenna effect can be expected in the longer wavelength region.

2.2 Device fabrication

The SOI nanowire PD with bow-tie nanoantenna is fabricated on a commercial SOI wafer. The top Si layer and the substrate have p-type conduction, and the initial impurity (boron) concentration is $1 \times 10^{15} \text{ cm}^{-3}$. Thickness of the top Si layer is 60 nm, which is adjusted by thermal oxidation of the Si and removal of the oxide. The buried oxide (BOX) thickness is 400 nm. Insulator between the bow-tie nanoantenna and Si nanowire is SiO_2 with thickness of 20 nm. The cathode of the PD is formed by thermal diffusion of phosphorus. Phospho-silicate spin-on-glass (PSG) is spun on SOI, then phosphorus is diffused at 880°C for 20 minutes to achieve concentration $> 2 \times 10^{19} \text{ cm}^{-3}$. After removing PSG, the top silicon layer is patterned broadly by UV lithography to isolate PD from adjacent devices. The p-type Si region will form a channel connecting the cathode and anode of the PD. This channel is in the form of nanowires of various W_{Si} from 72 to 150 nm, patterned using EBL system (JEOL JBX-6300SP) with EB energy of 100 keV and dosage of $160 \mu\text{C}/\text{cm}^2$ for 100-nm-thick EB resist (Nippon Zeon ZEP-520A), and etched using SF_6/O_2 -based reactive ion etching (SAMCO RIE-10NR). Nanowire will also act as the photosensitive region of the PD.

To enhance the photogeneration of carriers in the nanowire, Au nanoantennas in the shape of a bow tie with various designed L_{ANT} from 240 to 400 nm and L_c from 40 to 72 nm have been fabricated using resist lift-off technique. Firstly, the bow-tie shape is patterned using EBL with the same condition as that for delineating the top Si layer. After the exposure and development of EB resist, 5 nm of titanium (Ti) and 50 nm of Au are deposited by EB evaporation at a slow rate of 0.5 nm/s to improve the surface morphology. Finally, the developed resist is lifted off by ultrasonic agitation to fabricate the pattern. Ti is inserted to improve adhesion strength between Au and SiO_2 , thereby improving the stability of the fabricated

Fig. 2. (a) SP propagation wavelength vs. wavelength in vacuum, and (b) extinction ratio for half-SP-wavelength propagation.

Fig. 3. FE-SEM enlarged view of the active area of Si nanowire PD with a bow-tie antenna.

nanostructure during lift-off. Fig. 3 shows field emission scanning electron microscopy (FE-SEM) image of the PD with W_{Si} , L_{ANT} and L_{C} of 150, 240 and 40 nm, respectively. External electrical biases are applied to contact pads, i.e. anode, cathode and two gates.

Since the bow tie is closed, a nanogap is created at the junction by flowing current and inducing electromigration [27]. The excited SP leads to the enhancement of the electric field near the nanogap [24]. The optical near field will generate the carriers within the depleted Si nanowire, thereby increasing the cathode current.

For optical measurement, the device is illuminated by the light through a monochromator with wavelength range from 400 to 800 nm. The spectroscopic response of the SOI PD before and after formation of nanogap by breaking the bow-tie nanoantenna is measured at $T = 300$ K with biasing of V_{C} , V_{G} and V_{SUB} at 1, 0 and -20 V, respectively.

2.3 Numerical simulation

Using the three-dimensional (3D) finite difference time domain (FDTD) method, the near-field profile in the Au bow-tie antenna had been simulated. It is a reliable technique in solving Maxwell's equations in dispersive media. Si, Au, and Ti were specified by frequency-dependent permittivity $\varepsilon(\omega)$ [12].

The FDTD simulations were carried out using the FullWAVE (RSOFT, Inc.). The quasi-plane wave irradiates the bowtie antenna on the SOI PD. The incident plane wave is linearly polarized light along the antenna length direction with wavelength λ from 400 to 800 nm, and propagates along the height direction of SOI PD. In this paper, the results in the cases with and without the gap are compared to clarify the field concentration effect of SP mode at the gap. The calculation domain with $1000 \times 1000 \times 630 \text{ nm}^3$ (domain size in x , y , z direction) was considered with a grid of 2 nm, but the length of SOI channel and the planar size of BOX/Si substrate are infinite using perfectly matched layer (PML) as an absorbing boundary condition. For the calculation of the effective detector area, which will be discussed later, the absorption of light in the Si nanowire volume of $200 \times 150 \times 60 \text{ nm}^3$ (length $\times$ width $\times$ thickness) is considered.

3 Results and discussion

3.1 Nanogap formation

Fig. 4(a) shows the circuit diagram for breaking the bow-tie nanoantenna by controlled passage of current for formation of nanogap. The current flowing through the bow-tie nanoantenna is monitored. As shown in Fig. 4(b) the resistance at the onset of current flow (before breaking) is calculated to be around 60 G Ω at 40 mV. As the voltage across the antenna increases, the current also increases. At sufficiently high voltage, the current suddenly drops indicating the breaking of junction by electromigration. The resistance calculated after breaking the bow-tie nanoantenna is more than 2 T Ω .

The change in tunnel resistance reflects the change in the nanogap size. Quantitatively, the tunnel conductance G_t is exponentially dependent on the size of the nanogap s formed at the center of the bow tie, and can be calculated by the equation $G_t = G_{t0} \exp -\alpha\sqrt{\Phi_S}$, where α is a characteristic length of tunneling ($= 1.025 \text{ \AA}^{-1} \text{ eV}^{-1/2}$), Φ is the work function of Au ($= 4 \text{ eV}$), and G_{t0} is typically 0.8 S [28].

For tunnel resistances of 2 T Ω after junction breaking, the nanogap size is estimated to be 1.4 nm.

3.2 Effective detector area

Fig. 5 shows the effective detector area (A_{Eff}) of the SOI PD with respect to the wavelength for $L_{\text{ANT}} = 240 \text{ nm}$ and $L_C = 40$ or 72 nm, before and after breaking the bow-tie antenna to create nanogap. The A_{Eff} is defined by

$$A_{\text{Eff}} = \frac{I_{\text{Ph}}}{e} \bigg/ \frac{P_{\text{Opt}}}{h\nu}, \quad (4)$$

where I_{Ph} , P_{Opt} , e , h and ν are photocurrent, optical power per unit area, electron charge, Plank's constant and light frequency, respectively. The A_{Eff} is introduced instead of external quantum efficiency since the light receiving area is not clear.

The A_{Eff} increases as the wavelength decreases, and shows a hump around the wavelength of 500 nm. This is due to the high absorption coefficient of Si for the shorter wavelength region and the interferences in the multilayered structure [12].

In the wavelength range from 760 to 800 nm, enhancement of the A_{Eff} up to

Fig. 4. Break junction for nanogap formation. (a) Circuit diagram for junction breaking. (b) Current vs. voltage curves during and after the nanogap formation.

Fig. 5. Effective detector area A_{Eff} vs. wavelength for $L_{\text{ANT}} = 240$ nm and $W_{\text{Si}} = 150$ nm.

50% by the formation of nanogap is successfully observed for the $L_C = 40$ nm. The PD with $L_C = 72$ nm does not show clear enhancement, probably because the concentration of the electromagnetic field is insufficient for the wider junction of the bow tie. The wavelength range for the enhancement is unexpectedly long for $L_{\text{ANT}} = 240$ nm considering the SP propagation wavelength in Fig. 2(a). This might be attributed to the collective electron oscillation in the entire thickness of the thin Au layer [29].

3.3 Numerical analysis

Fig. 6 shows the simulated electric energy profile, W_e [J/m³], of the Au bow-tie nanoantenna with $L_{\text{ANT}} = 240$ nm, with and without nanogap of 10 nm for the incident light with the power density of 1 W/μm² and the wavelength of 720 nm. This wavelength is close to the SP resonance wavelength of the nanoantenna. The

Fig. 6. Simulated electric energy profile, $W_e = (1/2)\epsilon|E|^2$ [J/m³], for Au bow-tie nanoantenna of $L_{\text{ANT}} = 240$ nm, $L_C = 40$ nm and $W_{\text{Si}} = 150$ nm illuminated by incident light with the wavelength of 720 nm. (a) top and (b) cross-sectional views without nanogap, and (c) top and (d) cross-sectional views with nanogap of 10 nm.

gap size of 10 nm is selected to make the enhancement more visible since the range of the intense near field is in the order of the gap size, and the separation between the nanoantenna and the Si nanowire, i.e. the insulator (SiO₂) thickness, is 20 nm.

As is observed in Fig. 6(a), electric energy is concentrated at the neck of the bow tie. By creating a nanogap, the density of electric energy is increased, and the intense electric energy is distributed inside the nanoantennas shown in Fig. 6(c). Comparing the cross-sectional views in Fig. 6(b) and (d) the intensity of electric field in the case with gap is much larger resulting in the enhancement of light absorption. Consequently, the cathode current would be increased.

Fig. 7 is the spectroscopic effective detector areas A_{Eff} in the cases with and without 10-nm gap, and the enhancement factor by the nanogap. The enhancement factor larger than unity can be seen in the wavelength range from 660 nm to 780 nm. The presence of nanogap of 10 nm in the neck of bow-tie nanoantenna increases the light absorption in the specified region in Si nanowire by more than 50% at wavelengths around 720 nm. Similar characteristics have also been observed in the measured results in Fig. 5. In the experimental data, the A_{Eff} is larger than that of the simulated one, and the enhancement factor is smaller. The former is probably caused by the contribution of the larger Si area compared to the one ($200 \times 150 \text{ nm}^2$) assumed in simulation. The latter is mainly due to the use of un-polarized light and the narrower gap in the experiment.

Fig. 7. Simulated effective detector area A_{Eff} vs. wavelength for $L_{\text{ANT}} = 240 \text{ nm}$ and $W_{\text{Si}} = 150 \text{ nm}$.

4 Conclusions

We fabricated the SOI nanowire PD with Au bow-tie nanoantenna having minimum feature size of 40 nm by EBL, and nanogap at the center with estimated size of $\sim 1.4 \text{ nm}$ by electromigration. The A_{Eff} of the SOI nanowire PD were compared before and after the nanogap formation, and the enhancement up to 50% was successfully observed in the wavelength range from 760 to 800 nm for $L_{\text{ANT}} = 240 \text{ nm}$. FDTD simulation was also carried out to confirm the concentration of the electric energy around the nanogap, and the enhanced A_{Eff} . The

bow-tie nanoantenna with an electromigration-induced nanogap would be a unique measure to improve the efficiency of various nanometer-scale photonic devices.

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